

# NDF11N50Z

## N-Channel Power MOSFET 500 V, 0.52 Ω

### Features

- Low ON Resistance
- Low Gate Charge
- ESD Diode–Protected Gate
- 100% Avalanche Tested
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

### ABSOLUTE MAXIMUM RATINGS ( $T_C = 25^\circ\text{C}$ unless otherwise noted)

Rating	Symbol	NDF	Unit
Drain–to–Source Voltage	$V_{DSS}$	500	V
Continuous Drain Current, $R_{\theta JC}$ (Note 1)	$I_D$	12	A
Continuous Drain Current $T_A = 100^\circ\text{C}$ , $R_{\theta JC}$ (Note 1)	$I_D$	7.4	A
Pulsed Drain Current, $t_P = 10 \mu\text{s}$	$I_{DM}$	44	A
Power Dissipation, $R_{\theta JC}$	$P_D$	39	W
Gate–to–Source Voltage	$V_{GS}$	$\pm 30$	V
Single Pulse Avalanche Energy, $I_D = 10 \text{ A}$	$E_{AS}$	420	mJ
ESD (HBM) (JESD22–A114)	$V_{esd}$	4000	V
RMS Isolation Voltage ( $t = 0.3 \text{ sec.}$ , R.H. $\leq 30\%$ , $T_A = 25^\circ\text{C}$ ) (Figure 14)	$V_{ISO}$	4500	V
Peak Diode Recovery (Note 2)	$dv/dt$	4.5	V/ns
MOSFET $dV/dt$	$dV/dt$	60	V/ns
Continuous Source Current (Body Diode)	$I_S$	12	A
Maximum Temperature for Soldering Leads	$T_L$	260	$^\circ\text{C}$
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$	$-55$ to $150$	$^\circ\text{C}$

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

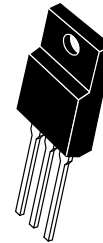
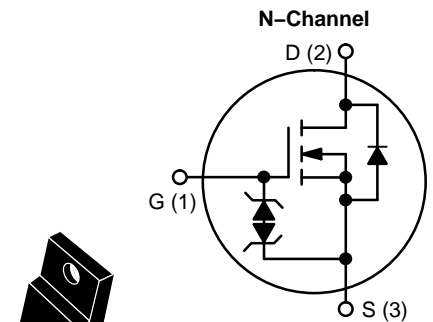
1. Limited by maximum junction temperature
2.  $I_d \leq 10.5 \text{ A}$ ,  $di/dt \leq 200 \text{ A}/\mu\text{s}$ ,  $V_{DD} \leq BV_{DSS}$ ,  $T_J \leq 150^\circ\text{C}$ .



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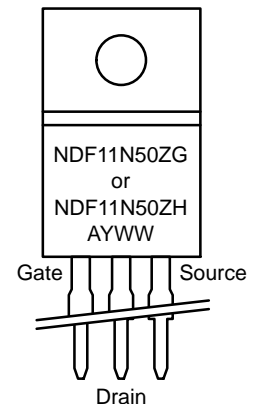
[www.onsemi.com](http://www.onsemi.com)

$V_{DSS}$	$R_{DS(ON)} \text{ (MAX) @ } 4.5 \text{ A}$
500 V	0.52 Ω



NDF11N50ZG  
NDF11N50ZH  
TO–220FP  
CASE 221AH

### MARKING DIAGRAM



- A = Location Code
- Y = Year
- WW = Work Week
- G, H = Pb–Free, Halogen–Free Package

### ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

# NDF11N50Z

## THERMAL RESISTANCE

Parameter	Symbol	NDF11N50Z	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	3.2	°C/W
Junction-to-Ambient Steady State (Note 3)	$R_{\theta JA}$	50	

## ELECTRICAL CHARACTERISTICS ( $T_J = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Test Conditions	Symbol	Min	Typ	Max	Unit
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### OFF CHARACTERISTICS

Drain-to-Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = 1\text{ mA}$	$BV_{DSS}$	500			V
Breakdown Voltage Temperature Coefficient	Reference to $25^\circ\text{C}$ , $I_D = 1\text{ mA}$	$\Delta BV_{DSS}/\Delta T_J$		0.6		V/°C
Drain-to-Source Leakage Current	$V_{DS} = 500\text{ V}, V_{GS} = 0\text{ V}$	$I_{DSS}$	25°C		1	μA
			125°C		50	
Gate-to-Source Forward Leakage	$V_{GS} = \pm 20\text{ V}$	$I_{GSS}$			±10	μA

### ON CHARACTERISTICS (Note 4)

Static Drain-to-Source On-Resistance	$V_{GS} = 10\text{ V}, I_D = 4.5\text{ A}$	$R_{DS(on)}$		0.48	0.52	Ω
Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 100\text{ }\mu\text{A}$	$V_{GS(th)}$	3.0	3.9	4.5	V
Forward Transconductance	$V_{DS} = 15\text{ V}, I_D = 4.5\text{ A}$	$g_{FS}$		7.7		S

### DYNAMIC CHARACTERISTICS

Input Capacitance (Note 5)	$V_{DS} = 25\text{ V}, V_{GS} = 0\text{ V},$ $f = 1.0\text{ MHz}$	$C_{iss}$	1097	1375	1645	pF
Output Capacitance (Note 5)		$C_{oss}$	132	166	199	
Reverse Transfer Capacitance (Note 5)		$C_{rss}$	30	40	50	
Total Gate Charge (Note 5)	$V_{DD} = 250\text{ V}, I_D = 10.5\text{ A},$ $V_{GS} = 10\text{ V}$	$Q_g$	23	46	69	nC
Gate-to-Source Charge (Note 5)		$Q_{gs}$	4.5	8.7	13	
Gate-to-Drain ("Miller") Charge (Note 5)		$Q_{gd}$	12.5	25	37.5	
Plateau Voltage		$V_{GP}$		6.2		V
Gate Resistance		$R_g$		1.4		Ω

### RESISTIVE SWITCHING CHARACTERISTICS

Turn-On Delay Time	$V_{DD} = 250\text{ V}, I_D = 10.5\text{ A},$ $V_{GS} = 10\text{ V}, R_G = 5\text{ }\Omega$	$t_{d(on)}$		15		ns
Rise Time		$t_r$		32		
Turn-Off Delay Time		$t_{d(off)}$		40		
Fall Time		$t_f$		23		

### SOURCE-DRAIN DIODE CHARACTERISTICS ( $T_C = 25^\circ\text{C}$ unless otherwise noted)

Diode Forward Voltage	$I_S = 10.5\text{ A}, V_{GS} = 0\text{ V}$	$V_{SD}$			1.6	V
Reverse Recovery Time	$V_{GS} = 0\text{ V}, V_{DD} = 30\text{ V}$ $I_S = 10.5\text{ A}, di/dt = 100\text{ A}/\mu\text{s}$	$t_{rr}$		310		ns
Reverse Recovery Charge		$Q_{rr}$		2.5		μC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Insertion mounted
4. Pulse Width  $\leq 380\text{ }\mu\text{s}$ , Duty Cycle  $\leq 2\%$ .
5. Guaranteed by design.

# NDF11N50Z

## TYPICAL CHARACTERISTICS

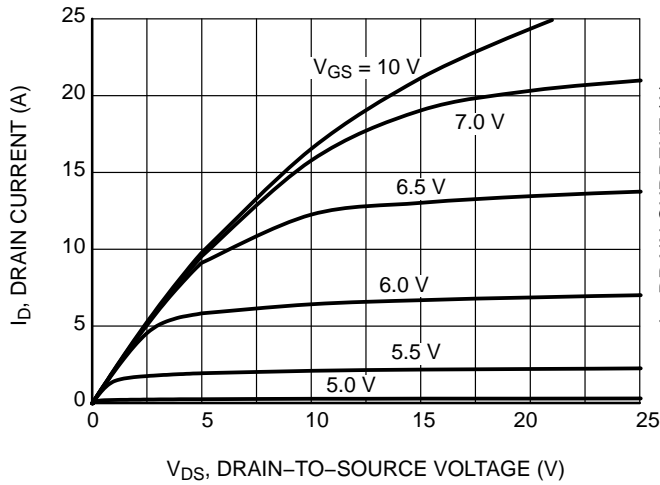


Figure 1. On-Region Characteristics

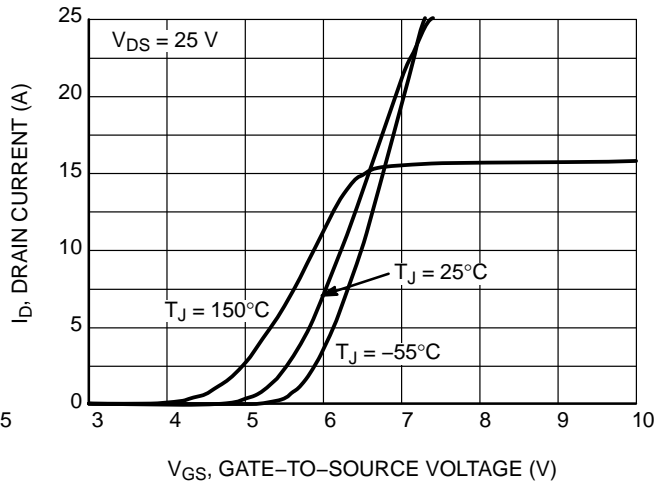


Figure 2. Transfer Characteristics

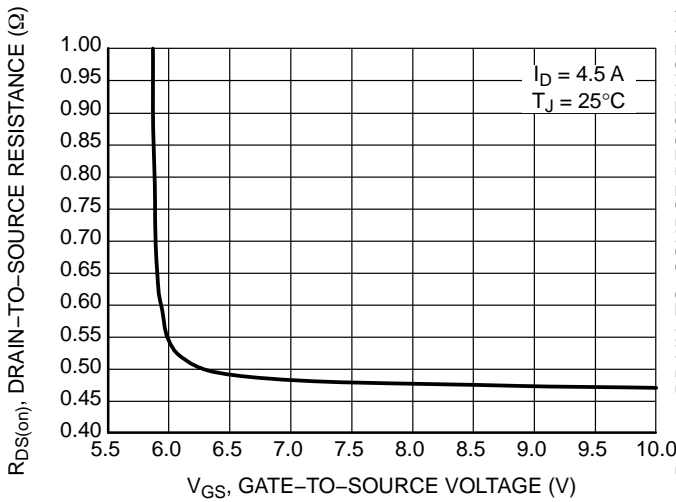


Figure 3. On-Region versus Gate-to-Source Voltage

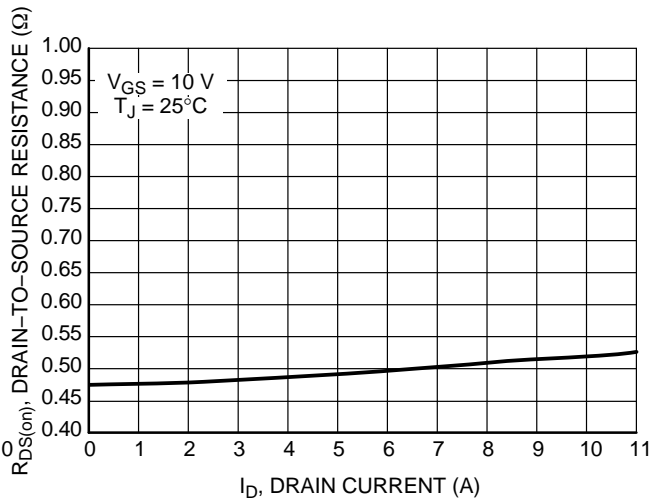


Figure 4. On-Resistance versus Drain Current and Gate Voltage

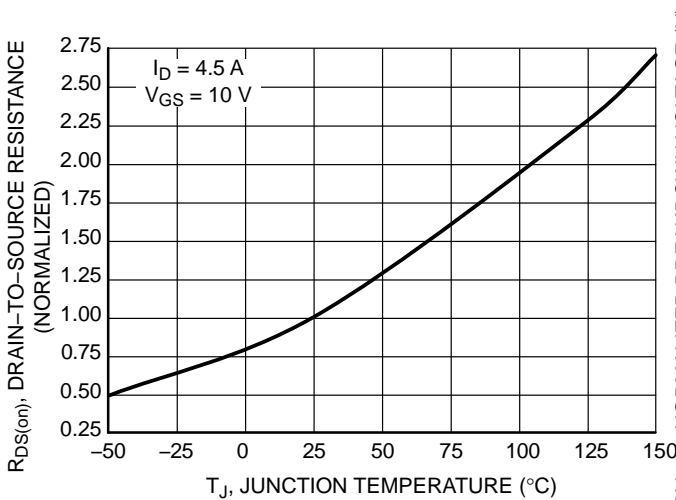


Figure 5. On-Resistance Variation with Temperature

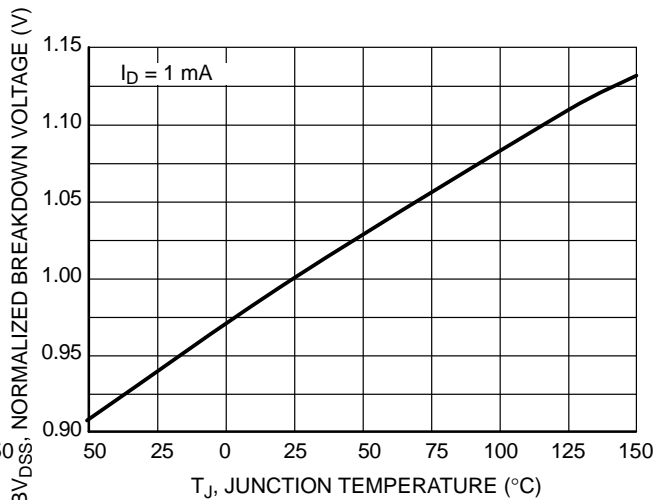
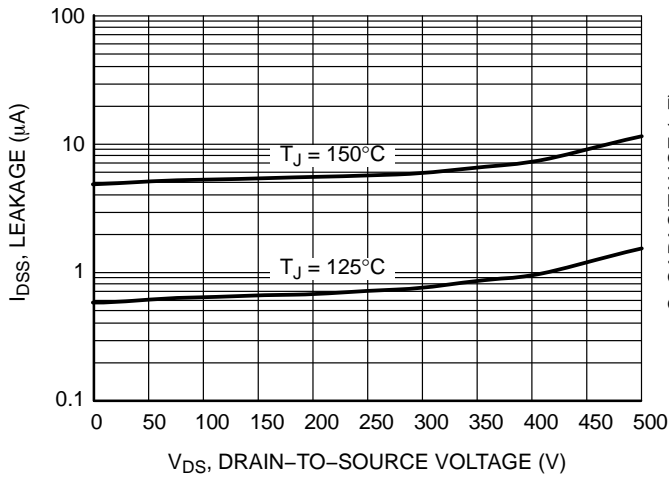


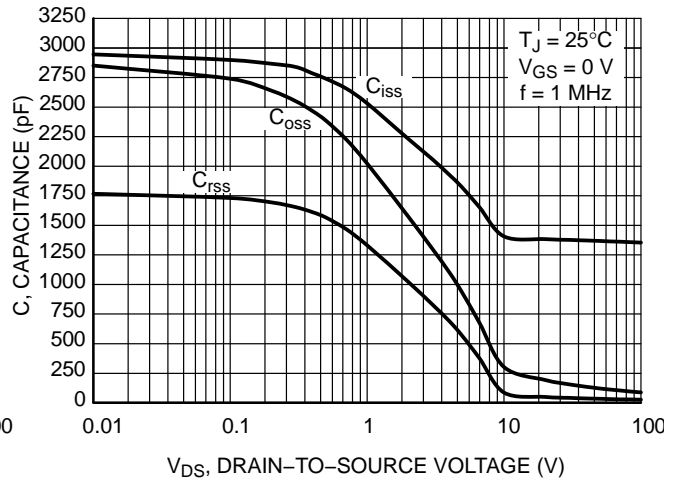
Figure 6.  $BV_{DSS}$  Variation with Temperature

# NDF11N50Z

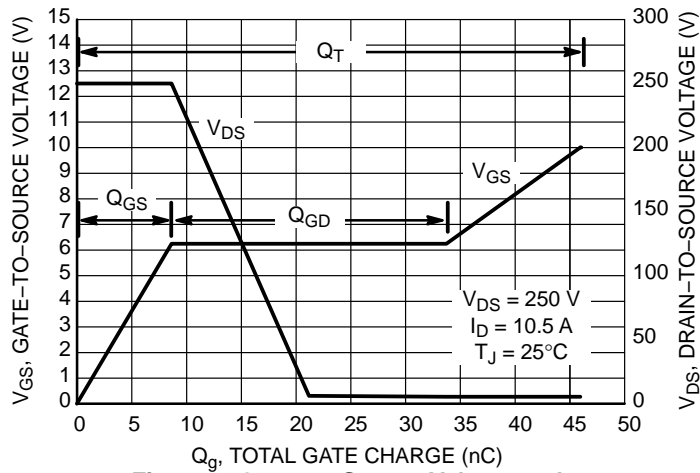
## TYPICAL CHARACTERISTICS



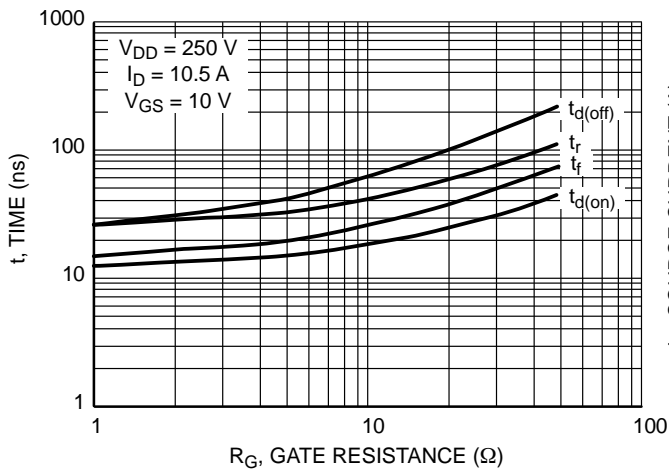
**Figure 7. Drain-to-Source Leakage Current versus Voltage**



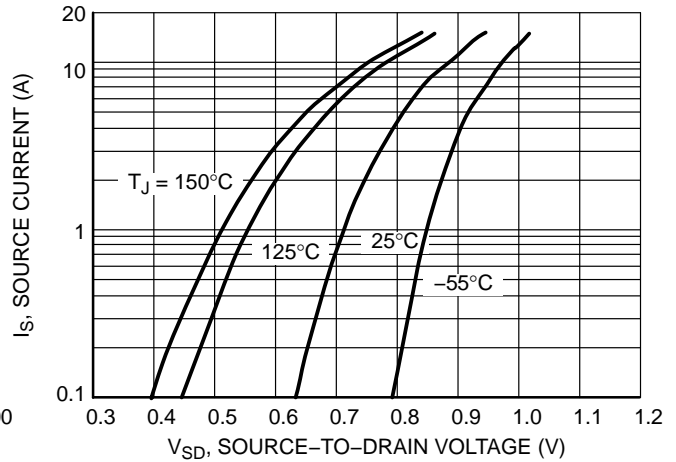
**Figure 8. Capacitance Variation**



**Figure 9. Gate-to-Source Voltage and Drain-to-Source Voltage versus Total Charge**



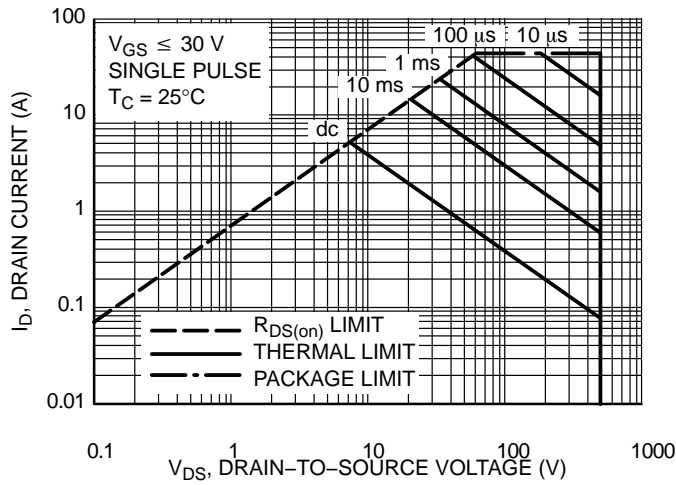
**Figure 10. Resistive Switching Time Variation versus Gate Resistance**



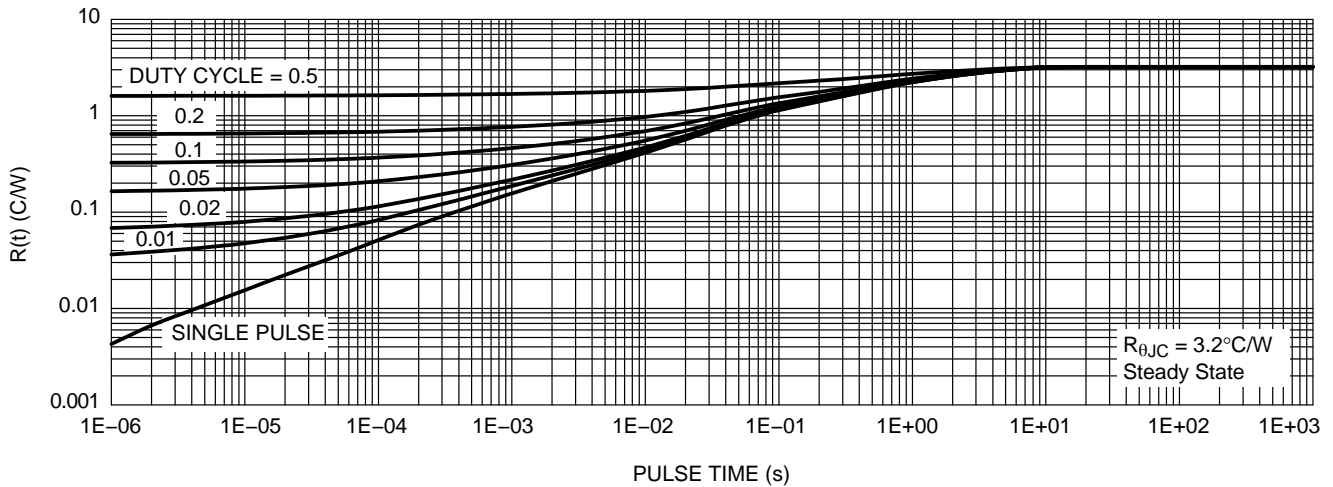
**Figure 11. Diode Forward Voltage versus Current**

# NDF11N50Z

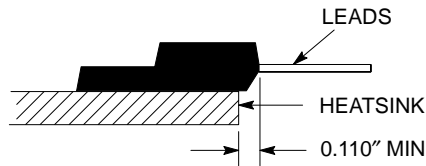
## TYPICAL CHARACTERISTICS



**Figure 12. Maximum Rated Forward Biased Safe Operating Area NDF11N50Z**



**Figure 13. Thermal Impedance (Junction-to-Case) for NDF11N50Z**



**Figure 14. Isolation Test Diagram**

Measurement made between leads and heatsink with all leads shorted together.

\*For additional mounting information, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

# NDF11N50Z

## ORDERING INFORMATION

Order Number	Package	Shipping
NDF11N50ZG	TO-220FP (Pb-Free, Halogen-Free)	50 Units / Rail
NDF11N50ZH	TO-220FP (Pb-Free, Halogen-Free)	50 Units / Rail

# MECHANICAL CASE OUTLINE

## PACKAGE DIMENSIONS

ON Semiconductor®



### TO-220 FULLPACK, 3-LEAD CASE 221AH ISSUE F

DATE 30 SEP 2014



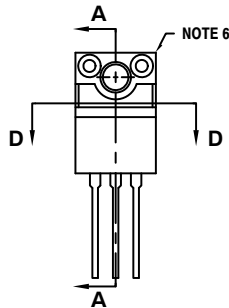
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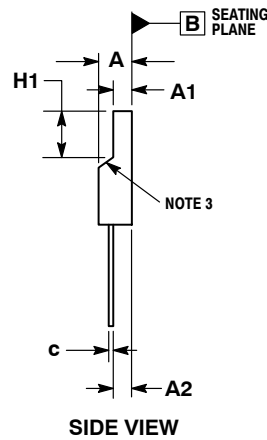
FRONT VIEW



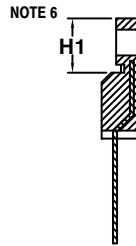
SECTION D-D



ALTERNATE CONSTRUCTION



SIDE VIEW



SECTION A-A

NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. CONTOUR UNCONTROLLED IN THIS AREA.
4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH AND GATE PROTRUSIONS. MOLD FLASH AND GATE PROTRUSIONS NOT TO EXCEED 0.13 PER SIDE. THESE DIMENSIONS ARE TO BE MEASURED AT OUTERMOST EXTREME OF THE PLASTIC BODY.
5. DIMENSION b2 DOES NOT INCLUDE DAMBAR PROTRUSION. LEAD WIDTH INCLUDING PROTRUSION SHALL NOT EXCEED 2.00.
6. CONTOURS AND FEATURES OF THE MOLDED PACKAGE BODY MAY VARY WITHIN THE ENVELOPE DEFINED BY DIMENSIONS A1 AND H1 FOR MANUFACTURING PURPOSES.

MILLIMETERS		
DIM	MIN	MAX
A	4.30	4.70
A1	2.50	2.90
A2	2.50	2.90
b	0.54	0.84
b2	1.10	1.40
c	0.49	0.79
D	14.70	15.30
E	9.70	10.30
e	2.54 BSC	
H1	6.60	7.10
L	12.50	14.73
L1	---	2.80
P	3.00	3.40
Q	2.80	3.20

#### GENERIC MARKING DIAGRAM\*



- A = Assembly Location
- WL = Wafer Lot
- Y = Year
- WW = Work Week
- G = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "▪", may or may not be present.

STYLE 1:

1. MAIN TERMINAL 1
2. MAIN TERMINAL 2
3. GATE

STYLE 2:

1. CATHODE
2. ANODE
3. GATE

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DESCRIPTION:	TO-220 FULLPACK, 3-LEAD	PAGE 1 OF 1

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